

- ★ 100% EAS Guaranteed
- ★ Green Device Available
- ★ Super Low Gate Charge
- ★ Excellent CdV/dt effect decline
- ★ Advanced high cell density Trench technology

### Product Summary



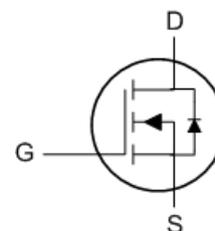
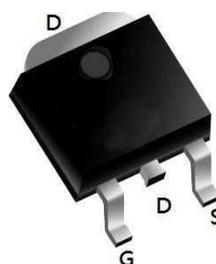
BVDSS	RDSON	ID
70V	5.5mΩ	80A

### Description

The XR80N07 is the high cell density trenched N-ch MOSFETs, which provide excellent RDSON and gate charge for most of the synchronous buck converter applications.

The XR80N07 meet the RoHS and Green Product requirement 100% EAS guaranteed with full function reliability approved.

### TO252-3L Pin Configuration



### Absolute Maximum Ratings

Symbol	Parameter	Rating	Units
$V_{DS}$	Drain-Source Voltage	70	V
$V_{GS}$	Gate-Source Voltage	$\pm 20$	V
$I_D@T_C=25^\circ C$	Continuous Drain Current, $V_{GS} @ 10V^{1,6}$	80	A
$I_D@T_C=100^\circ C$	Continuous Drain Current, $V_{GS} @ 10V^{1,6}$	60	A
$I_{DM}$	Pulsed Drain Current <sup>2</sup>	364	A
EAS	Single Pulse Avalanche Energy <sup>3</sup>	400	mJ
$I_{AS}$	Avalanche Current	---	A
$P_D@T_C=25^\circ C$	Total Power Dissipation <sup>4</sup>	136	W
$T_{STG}$	Storage Temperature Range	-55 to 150	$^\circ C$
$T_J$	Operating Junction Temperature Range	-55 to 150	$^\circ C$

### Thermal Data

Symbol	Parameter	Typ.	Max.	Unit
$R_{\theta JA}$	Thermal Resistance Junction-Ambient <sup>1</sup>	---	---	$^\circ C/W$
$R_{\theta JC}$	Thermal Resistance Junction-Case <sup>1</sup>	---	1.1	$^\circ C/W$

### Electrical Characteristics (T<sub>J</sub>=25 °C, unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V, I <sub>D</sub> =250uA	0	---	---	V
ΔBV <sub>DSS</sub> /ΔT <sub>J</sub>	BV <sub>DSS</sub> Temperature Coefficient	Reference to 25°C, I <sub>D</sub> =1mA	---	---	---	V/°C
R <sub>DS(ON)</sub>	Static Drain-Source On-Resistance <sup>2</sup>	V <sub>GS</sub> =10V, I <sub>D</sub> =1A	---	5.5	7	mΩ
V <sub>GS(th)</sub>	Gate Threshold Voltage	V <sub>GS</sub> =V <sub>DS</sub> , I <sub>D</sub> =250uA	G	3	1	V
ΔV <sub>GS(th)</sub>	V <sub>GS(th)</sub> Temperature Coefficient		---	---	---	mV/°C
I <sub>DSS</sub>	Drain-Source Leakage Current	V <sub>DS</sub> =10V, V <sub>GS</sub> =0V, T <sub>J</sub> =25°C	---	---	1	uA
		V <sub>DS</sub> =10V, V <sub>GS</sub> =0V, T <sub>J</sub> =100°C	---	---	100	
I <sub>GSS</sub>	Gate-Source Leakage Current	V <sub>GS</sub> =±20V, V <sub>DS</sub> =0V	---	---	±100	nA
g <sub>fs</sub>	Forward Transconductance	V <sub>DS</sub> =FV, I <sub>D</sub> =20A	---	H	---	S
R <sub>g</sub>	Gate Resistance	V <sub>DS</sub> =0V, V <sub>GS</sub> =0V, f=1MHz	---	€7	---	Ω
Q <sub>g</sub>	Total Gate Charge	V <sub>DS</sub> =H V, V <sub>GS</sub> =10V, I <sub>D</sub> =20A	---	ïï	---	nC
Q <sub>gs</sub>	Gate-Source Charge		---	Fï	---	
Q <sub>gd</sub>	Gate-Drain Charge		---	œ	---	
T <sub>d(on)</sub>	Turn-On Delay Time	VGS=10V, VDD=H V, RG=Î Ω	---	14.ï	---	ns
T <sub>r</sub>	Rise Time		---	H€	---	
T <sub>d(off)</sub>	Turn-Off Delay Time		---	íJ€	---	
T <sub>f</sub>	Fall Time		---	F2	---	
C <sub>iss</sub>	Input Capacitance	V <sub>DS</sub> =H V, V <sub>GS</sub> =0V, f=1MHz	---	4723	---	pF
C <sub>oss</sub>	Output Capacitance		---	225	---	
C <sub>rss</sub>	Reverse Transfer Capacitance		---	207	---	

### Diode Characteristics

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
I <sub>S</sub>	Continuous Source Current <sup>1,4</sup>	V <sub>G</sub> =V <sub>D</sub> =0V, Force Current	---	---	ì€	A
V <sub>SD</sub>	Diode Forward Voltage <sup>2</sup>	V <sub>GS</sub> =0V, I <sub>S</sub> =1A, T <sub>J</sub> =25C	---	---	1.2	V
t <sub>rr</sub>	Reverse Recovery Time	IF=20A, di/dt=100A/μs, T <sub>J</sub> =25C	---	GJ	---	nS
Q <sub>rr</sub>	Reverse Recovery Charge		---	Hí	---	nC

Note :

F The data is tested by surface mounted on a 1 inch<sup>2</sup> FR-4 board with 20Z copper.

G The data is tested by pulsed pulse width is 300us duty cycle is 2%

H The EAS data shows Max. Rating at the test condition is A/RMG »0, VDD=40V, VG=10V, Rg=25Ω, L=0.5mH.

I The power dissipation is limited by 50 °C junction temperature

í The data is theoretically the same as A<sub>DM</sub> and A<sub>DM</sub> in real applications should be limited by total power dissipation.

### Typical Electrical And Thermal Characteristics (Curves)

Figure 1. Output Characteristics

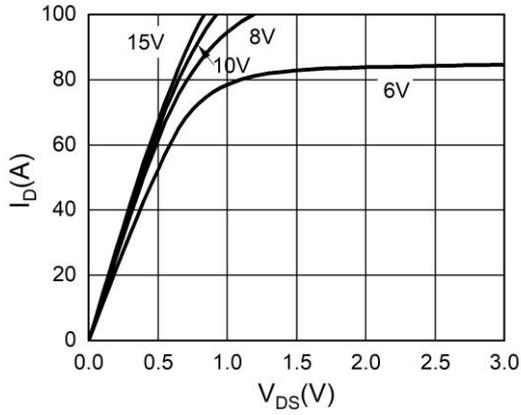


Figure 2. Transfer Characteristics

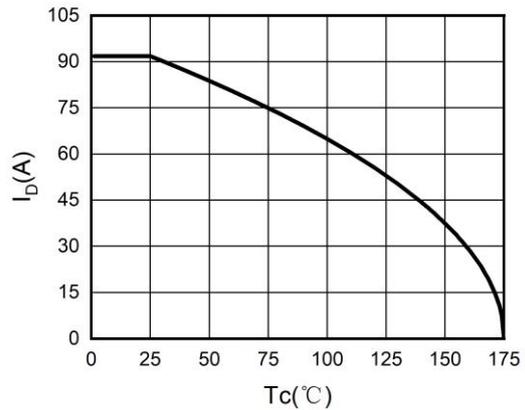
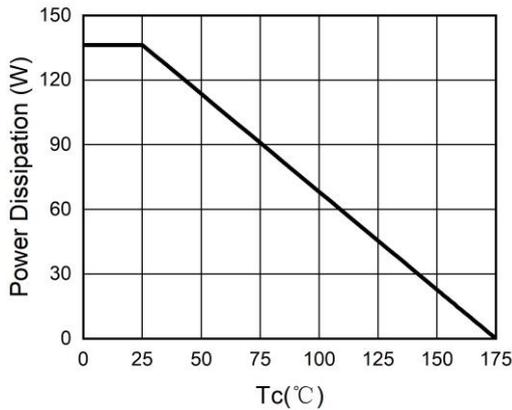
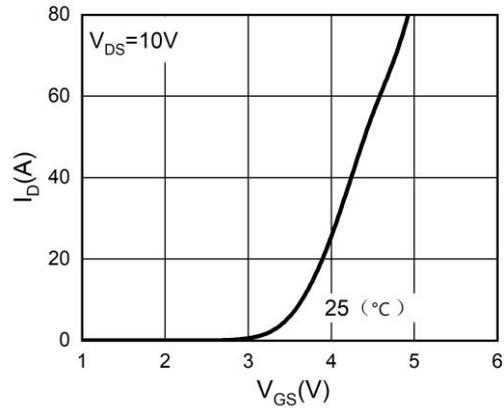


Figure 5.  $BV_{DSS}$  vs Junction Temperature

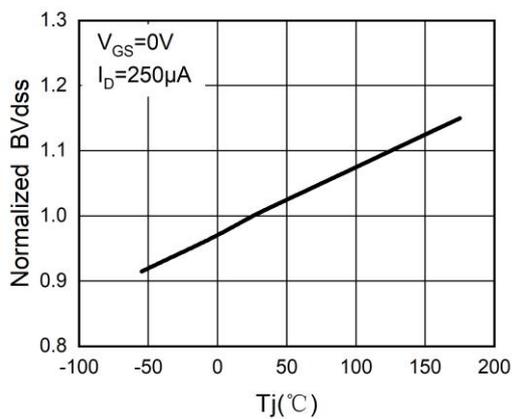
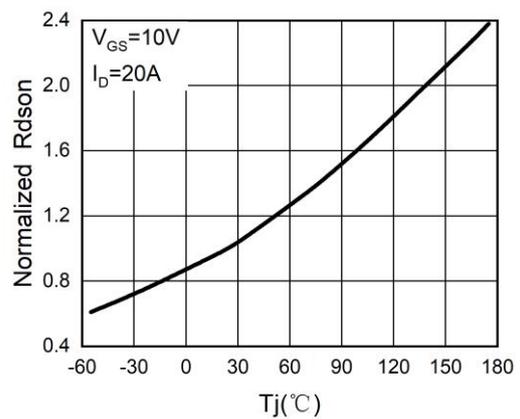
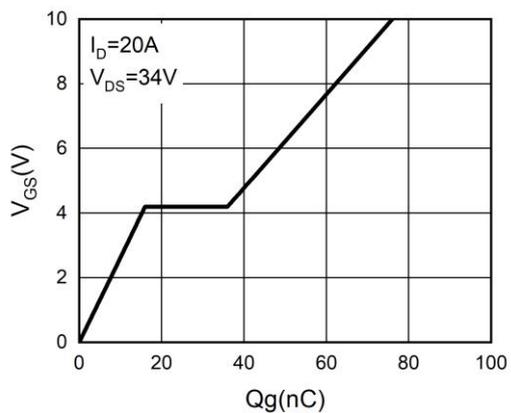


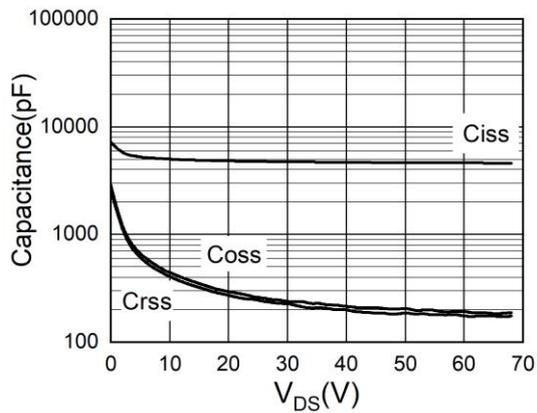
Figure 6.  $R_{DS(ON)}$  vs Junction Temperature



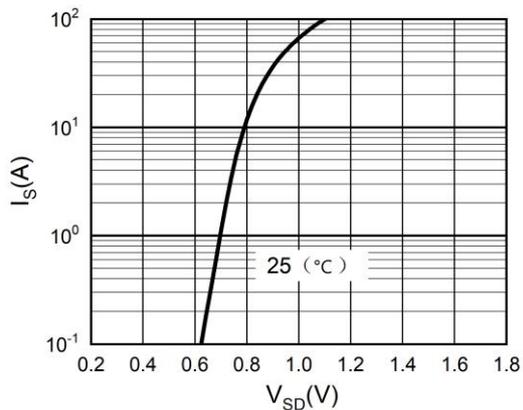
**Figure 7. Gate Charge Waveforms**



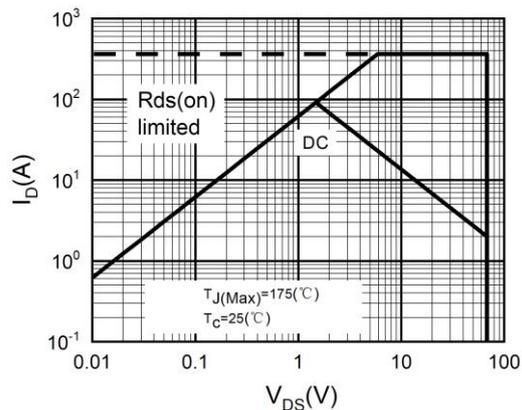
**Figure 8. Capacitance**



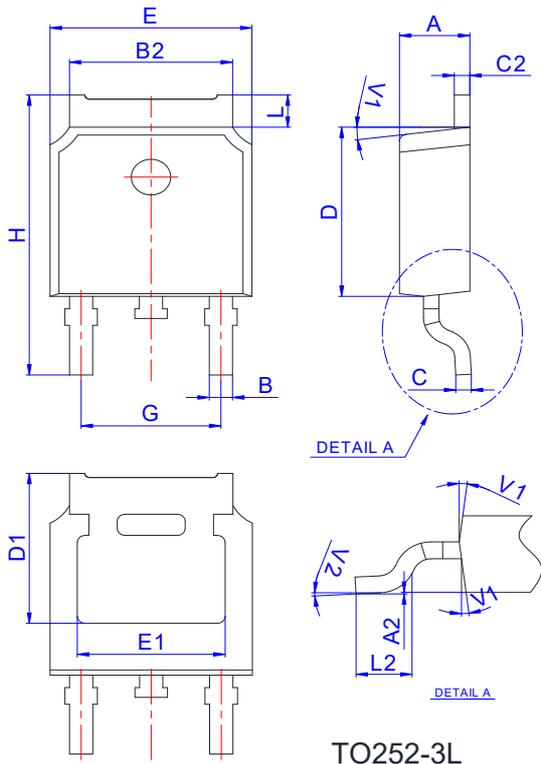
**Figure 9. Body-Diode Characteristics**



**Figure 10. Maximum Safe Operating Area**

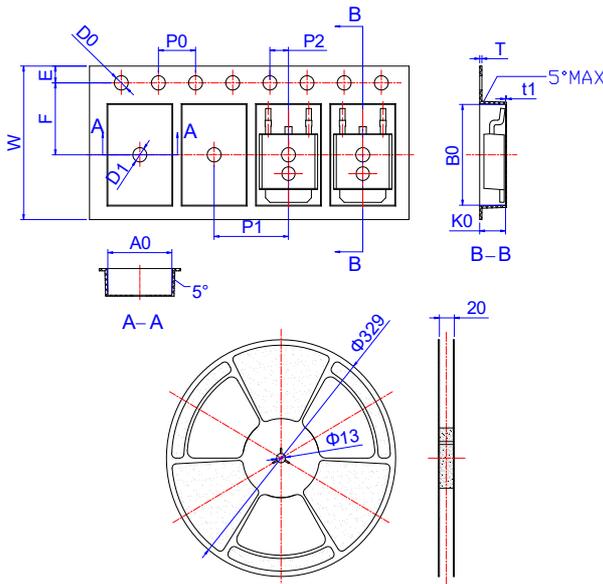


### Package Mechanical Data-TO252-3L



Ref.	Dimensions					
	Millimeters			Inches		
	Min.	Typ.	Max.	Min.	Typ.	Max.
A	2.10		2.50	0.083		0.098
A2	0		0.10	0		0.004
B	0.66		0.86	0.026		0.034
B2	5.18		5.48	0.202		0.216
C	0.40		0.60	0.016		0.024
C2	0.44		0.58	0.017		0.023
D	5.90		6.30	0.232		0.248
D1	5.30REF			0.209REF		
E	6.40		6.80	0.252		0.268
E1	4.63			0.182		
G	4.47		4.67	0.176		0.184
H	9.50		10.70	0.374		0.421
L	1.09		1.21	0.043		0.048
L2	1.35		1.65	0.053		0.065
V1		7°			7°	
V2	0°		6°	0°		6°

### Reel Specification-TO252-3L



Ref.	Dimensions					
	Millimeters			Inches		
	Min.	Typ.	Max.	Min.	Typ.	Max.
W	15.90	16.00	16.10	0.626	0.630	0.634
E	1.65	1.75	1.85	0.065	0.069	0.073
F	7.40	7.50	7.60	0.291	0.295	0.299
D0	1.40	1.50	1.60	0.055	0.059	0.063
D1	1.40	1.50	1.60	0.055	0.059	0.063
P0	3.90	4.00	4.10	0.154	0.157	0.161
P1	7.90	8.00	8.10	0.311	0.315	0.319
P2	1.90	2.00	2.10	0.075	0.079	0.083
A0	6.85	6.90	7.00	0.270	0.271	0.276
B0	10.45	10.50	10.60	0.411	0.413	0.417
K0	2.68	2.78	2.88	0.105	0.109	0.113
T	0.24		0.27	0.009		0.011
t1	0.10			0.004		
10P0	39.80	40.00	40.20	1.567	1.575	1.583